Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination MCGEE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0093420 A1	05-2003	Ramme, Kay P.	707/3
*	В	US-2004/0255293 A1	12-2004	Spotswood, Mark	717/176
*	C	US-2004/0255233 A1	12-2004	Croney et al.	715/500
*	D	US-6,370,549 B1	04-2002	Saxton, Thomas W.	707/205
*	Е	US-7,185,342 B1	02-2007	Carrer et al.	719/313
*	ш	US-2004/0172618 A1	09-2004	Marvin, Kyle	717/116
*	G	US-2004/0122912 A1	06-2004	Kim et al.	709/217
*	Η	US-2003/0191826 A1	10-2003	Bellinger et al.	709/220
*	ı	US-2004/0205564 A1	10-2004	Brayton et al.	715/513
*	J	US-2004/0054793 A1	03-2004	Coleman, Richard	709/229
*	К	US-2003/0229888 A1	12-2003	Spotswood et al.	717/116
	L	US-			
	М	US-			·

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
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	Р					
	Q					,
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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